

Application No.	Applicant(s)	
10/043,637	KHU ET AL.	
Examiner	Art Unit	
XUAN M. THAI	2111	

SEARCHED				
Class	Subclass	Date	Examiner	
710	5	6/27/2004	ХМТ	
710	300	6/27/2004	XMT	
714	30	6/27/2004	XMT	
714	724	6/27/2004	XMT	
714	725	6/27/2004	XMT	
714	726	6/27/2004	XMT	
714	734	6/27/2004	XMT	
716	4	6/27/2004	XMT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT; USPGPUB, EPO, JPO, DERWENT, IBMTDB	6/27/2004	XMT		
IEEE	6/27/2004	хмт		